Abstract—State of the art statistical timing analysis (STA) tools often yield less accurate results when timing variables become correlated. Spatial correlation and correlation caused by path reconvergence are among those which are most difficult to deal with. Existing methods treating these correlations will either suffer from high computational complexity or significant errors.

In this paper, we present a new sensitivity pruning method which will significantly reduce the computational cost to consider path reconvergence correlation. We also develop an accurate and efficient model to deal with the spatial correlation.

I. INTRODUCTION

When technology scales down to nanometer regime, environmental and process parameter variation will significantly affect circuit performance. Traditional corner-based timing analysis will generally be too pessimistic. Statistical timing analysis (STA) that characterizes timing delays as statistical random variables as a function of these parameter variations offers a better approach for more accurate and realistic timing prediction.

In literatures, there are two distinct approach for STA: path-based STA and block-based STA. The fundamental challenge of the path-based STA [2], [7], [9], [10] is its requirement to select a proper subset of paths whose time constraints are statistically critical. This task has a computation complexity that grows exponentially with respect to the circuit size, and hence can not be easily scaled to handle realistic circuits.

This potential difficulty has motivated the development of block-base STA [1], [3]–[6], [11], [13] that champions the notion of progressive computation. Specifically, statistical timing analysis is performed block by block in the forward direction in the circuit timing graph without looking back to the path history. As such, the computation complexity of block based STA will grow linearly with respect to the circuit size.

However, to realize the full benefit of block based STA, one must solve a difficult problem that timing variables in a circuit could be correlated due to inter-parameter dependency, chip-to-chip variation, within-chip spatial dependency, path reconvergence of the circuit. In [13], a framework called extended pseudo-canonical timing model has been proposed to take all these correlations into account for accurate timing: for a circuit with $N$ gates and $M$ global variation sources:

$$X = \mu_X + \sum_{i=1}^{N} \alpha_{X,i} R_i + \sum_{j=1}^{M} \beta_{X,j} G_j$$

where $r = [R_1, \ldots, R_N]^\ast$ represents gate’s localized independent variations and $g = [G_1, \ldots, G_M]^\ast$’s are global variations which may be correlated $E(gg^\ast) = \Sigma$.

By including the local variation terms $R_i$ in the timing model, all path reconvergence correlations can be automatically addressed but the increasing number of local variation terms can potentially cause significant penalty in CPU time when big circuit is analyzed. By allowing the global variations to be correlated, the timing model in equation (1) provides the capability to adapt arbitrary global parameter dependency, including spatial correlation, into consideration. But it is not clear how to use this timing model to treat the important spatial correlation since the only existing spatial correlation model in literature, quad-tree model, has significant errors.

A. Path Reconvergence

As mentioned above, the penalty to consider the path reconvergence correlation using the extended pseudo-canonical timing model is the worst-case timing complexity will be $O[N^2]$ instead of $O[N]$ since we have to traverse all local variation terms in equation (1) for every timing step. Authors in [13] propose to reduce the computation complexity by lumping small terms in the local variation sensitivity $\alpha_X = [\alpha_{X,1}, \ldots, \alpha_{X,N}]^\ast$ into an independent term. However, the worst-case timing complexity under such simple lumping approach, is still quadratic with respecting to the circuit size.

For example, for the circuit shown in figure 1, the lumping mechanism discussed in [13] will not work effectively since no local sensitivities can be lumped and the overall timing complexity will still be $O[N^2]$.

Fig. 1: Circuit with linear structure has timing complexity $O[N^2]$ since no small local sensitivity terms can be lumped.
B. Spatial Correlation

The only known spatial correlation model in literature is the so-called quad-tree model proposed in [1]. It covers the chip with grids and a structure of quad-tree is built to connect the grids cells together and the correlations between the parameters in the grid cells are represented by number of parent nodes they shared. However, this model might cause significant error since there are always nodes which are spatially very close to each other but belong to different subtrees in the quad-tree. So the correlation between these nodes might be significantly underestimated by this model.

![Quad-tree model](image)

Fig. 2: Quad-tree model underestimates the spatial correlation between wire segments 4 and 5

For example, if the quad-tree method is used to model the spatial correlation in an eight-segment straight wire, as illustrated in figure 2, the quad-tree will becomes a binary tree if the quad-partitioning is along the wire. It is obvious that the correlation between wire segments 2 and 3, 4 and 5 will be similar to that between wire segments 1 and 2 since they are similarly spatially separated. But according to the quad-tree method, the spatial correlation between 1 and 2 will be the largest, that between 3 and 4 will be second and that between 4 and 5 will be the smallest. So the quad-tree model fails to give similar spatial correlation when distance is similar.

C. Our Contribution

In this paper, we present solutions for both problems above. Specifically,

- By considering the fan-out number of gates, a fanout-based sensitivity pruning method, in addition to the original simple lumping method in [13], is developed to treat the correlation caused by path reconvergence and significant reduction in the number of local sensitivity terms is observed for benchmark circuits.

- We develop an analytical spatial correlation model without artificial errors as in quad-tree model. We propose to associate the grid size with the spatial correlation distance so as to efficiently integrate such an analytical model into statistical timing with the framework of [13].

The rest of the paper is organized as following: Section II discusses the fanout-based sensitivity pruning method; Section III describes our analytical spatial correlation model and the method to integrate such model into the statistical timing analysis; Section IV discusses the linear complexity of our timing algorithm with respect to the circuit size and the total number of global variations; Section V presents a real implementation of our method in C/C++ and the testing result with ISCAS85 benchmark suites; Section VI gives the conclusions.

II. Fanout-based Sensitivity Pruning

In previous section, we mentioned that the extended pseudo-canonical timing model will suffer from the quadratic computation complexity to consider the correlations caused by path reconvergence even with the simple lumping method introduced in [13]. This problem, however, can be greatly alleviated by considering the fanout number of gates.

For example, for the partial circuit shown in figure 3, if all local sensitivities involved in arrival times $A, B, C$ and $D$ are significant, then the simple lumping introduced in [13] will not reduce the number of the local sensitivity terms in the extended pseudo-canonical model. But if the fanout number of each gate is considered, some local sensitivity terms can still be pruned as illustrated in figure 3.

![Fanout-based sensitivity pruning](image)

Before fanout-based pruning

\[
A = \cdots + \alpha_{A0}R_0 + \cdots \\
B = \cdots + \alpha_{B0}R_0 + \alpha_{B1}R_1 + \cdots \\
C = \cdots + \alpha_{C0}R_0 + \alpha_{C2}R_2 + \cdots \\
D = \cdots + \alpha_{D0}R_0 + \alpha_{D1}R_1 + \alpha_{D2}R_2 + \alpha_{D3}R_3 + \cdots \\
\text{Average number of terms} = 2.25
\]

After fanout-based pruning

\[
A = \cdots + \alpha_{A0}R_0 + \cdots \\
B = \cdots + \alpha_{B0}R_0 + \alpha_{B1}R_1 + \cdots \\
C = \cdots + \alpha_{C0}R_0 + \alpha_{C2}R_2 + \cdots \\
D = \cdots + \alpha_{D0}R_0 + \sqrt{\alpha_{D1}^2 + \alpha_{D2}^2 + \alpha_{D3}^2}R_3 + \cdots \\
\text{Average number of terms} = 1.75
\]

Fig. 3: Fanout-based sensitivity pruning for arrival times $A, B, C$ and $D$ in an example circuit

Specifically, when the arrival time $D$ is computed, we can lump the local sensitivities $\alpha_{D1}$, $\alpha_{D2}$ and $\alpha_{D3}$ together because any path reconvergence related with gates 1 and 2 will always involve gate 3 due to the fact that gates 1 and 2 only has ONE fanout to gate 3. In another word, the path information included in the local variation term $R_3$ will automatically
imply the path information included in local variation terms \( R_1 \) and \( R_2 \). With such, lumping the local sensitivity of \( R_1 \) and \( R_2 \) into \( R_3 \) will reduce the path information redundancy and so that improve the computation efficiency. So such fanout-based sensitivity pruning will help gaining timing performance but will NOT hurt the timing accuracy since it is redundancy reduction instead of approximation.

The interesting thing we notice from the example circuit is that in the arrival time \( D \), the local variation \( R_0 \) can also be lumped since gate 0’s two fanouts have converged at gate 3. But it is difficult to decide such situation dynamically in timing analysis since it needs path trace which is computationally expensive. So the practical rule for fanout-based sensitivity pruning is:

If gate \( m \) has only one fanout to gate \( n \), then perform sensitivity pruning when computing the arrival time at gate \( n \)’s output as:

\[
\alpha_{n,new} = \sqrt{\alpha_{m}^2 + \alpha_{n,old}^2}
\]

It is also interesting to look back to section I. For circuit shown in figure 1, our fanout-based sensitivity pruning will work most efficiently since every gate in the circuit will have only one fanout and so that they are all right pruning candidates. So such worst case for the original simple lumping method actually becomes the best case for the proposed fanout-based sensitivity pruning method.

### III. Analytical Spatial Correlation Model

It has been widely known that the global parameters affecting the gate delays, such as gate length \( L \), voltage supply \( V \), temperature \( T \) etc., are not independent to each other. They might, on the other hand, correlate spatially, [8] i.e., devices nearby will have similar value of global parameters. So the fundamental property of the spatial correlation is that the correlation between the global parameters for gate at different positions will be a function of the distance between positions: the longer the distance, the smaller the correlation.

#### A. Exponential Spatial Correlation

Our approach for spatial correlation is to assume the correlation follows an analytical function of the distance. Such function can fundamentally be any analytical function that fits real calibration on silicon. As an illustrative example, here it is assumed to be an exponentially decay on the distances although the methodology here is not restricted to such exponential form. For a global parameter \( G_i \), as illustrated in figure 4(a), the covariance between the global variations at positions \( i \) and \( j \) will be:

\[
\text{cov}(G_i, G_j) = \sigma^2_i \exp\left(-\frac{r_{ij}}{r_c}\right)
\]

where \( \sigma^2_i \) is the variance of the considered global parameter, \( r_{ij} \) is the distance between positions \( i \) and \( j \); constant \( r_c \) is the characteristic spatial correlation distance of the considered global parameter. The longer the \( r_c \) is, the stronger the spatial correlation.

#### B. Spatial Correlation Resolution

To incorporate such analytical spatial correlation model into statistical timing analysis, the chip of the circuit is covered by grids and each grid cell is assigned an individual random global variation for the considered global parameter as shown in figure 4(a). All gates in the grid cell share the same global variation as assigned if the considered global parameter affects the gate delay. Different global parameter may be associated with different grids since they may have significant different spatial correlation distance.

Intuitively, it is desired for high modeling accuracy to have very fine grid. But fine grid will result in large covariance matrix so that it is not beneficial for it will significantly degrade the performance of the timing analysis. The key strategy we proposed to make a good trade-off between such accuracy and performance is to decide the grid size based on the spatial correlation distance of the considered global parameter through a user-defined parameter of resolution:

\[
\text{correlation\_distance} = \text{resolution} \times \text{grid\_cell\_size}
\]

So fine grid is only applied when the correlation distance is short or a high resolution is demanded. Although it seems that fine grid is inevitable since there is no guarantee that correlation distance is always large, performance will still be reasonable because the sparsity of the covariance matrix will be controlled by the \( \text{resolution} \) parameter.

![Spatial Correlation Matrix](image)

As shown in figure 4, the covariance matrix will always have a “band” structure where the number of bands in the matrix is decided by the user-defined parameter \( \text{resolution} \). The higher the resolution, the more bands and the less sparsity of the matrix. With the same resolution, the number of significant
elements in the covariance matrix is proportional to the number of global variations, i.e. the size of the covariance matrix.

IV. STATISTICAL TIMING COMPLEXITY

If time variables are with the extended pseudo-canonical timing model as in equation (1), the variation and covariance between such time variables will be [13]:

$$\sigma_X^2 = \alpha_X^2 + \beta_X^2 \Sigma$$

$$\text{cov}(X, Y) = \alpha_X \alpha_Y + \beta_X \beta_Y \Sigma$$ (3)

Consider the “band” structure of the covariance matrix $\Sigma$ as show in figure 4, the complexity to compute the variance and covariance will be $O[\Gamma + M]$ where $\Gamma$ is the average number of sensitivity terms in $\alpha$ and $M$ is the size of the $\Sigma$ or the total number of global variations. Since such variance/covariance evaluation has to be done at each timing step, the overall complexity of statistical timing will be $O[(\Gamma + M)N]$ which is still linear the circuit size $N$ since $\Gamma << N$ usually.

Since the number of bands in $\Sigma$ is controlled by the user-defined parameter of resolution, the higher the resolution, the more bands in the matrix and the longer the variance/covariance computation time. On the other hand, the higher the resolution, the finer the grid, the more accurate of the correlation model. So the user-defined parameter resolution provides a good way to trade off accuracy and complexity in considering spatial correlation for statistical timing.

V. SIMULATION RESULTS AND DISCUSSIONS

The above described algorithm has already been implemented in C/C++ and tested by ISCAS85 benchmark circuits. All tested circuits are synthesized using Design Compiler® from Synopsys®. Library cells used are characterized by Spice monte carlo simulation with Cadence® tools of Spectra® in 0.18μm technology and a 10%(σ/µ) variation is assumed in those process parameters. To model the spatial correlations, all tested circuits are placed by Dragon [12].

For illustration purpose, only three parameter variation are considered global: channel length(L), supply voltage(Vdd) and temperature(T). Although it is not necessary, their correlation distances are all assumed to be the same as 100μm. All other variation sources specified in the 0.18μm technology file are assumed to be localized in the considered gate only.

To test the effect of the proposed fanout-based sensitivity pruning method, all benchmark circuits are analyzed by our statistical timing engine with and without the sensitivity pruning method and the average number of local sensitivity terms are summarized in table I. In average, 32% of sensitivity reduction is achieved with the fanout-based pruning method. As discussed in section II and verified in table II, such sensitivity reduction will not affect the accuracy of the timing analysis although we can expect significant performance for large circuits.

VI. CONCLUSIONS

To consider the correlation caused by path reconvergence, this paper presents a novel method to additionally reduce the timing complexity with no accuracy penalty by introducing a fanout-based local sensitivity pruning method. In average, 32% of sensitivity term reduction is observed in ISCAS85 benchmark circuits.

An analytical spatial correlation model is also proposed to avoid the artificial error in the existing quad-tree model.
By constructing the grid covering the circuit according to the spatial correlation distance, the overall complexity of the timing analysis becomes linear with respecting to the total number of grid cells. A convenient parameter named resolution is used to make trade-off between the timing performance and spatial correlation accuracy.

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